Search Notes					

Application/Control N	lo. Applicant(s)/Patent under Reexamination
10/045,674	LADNER ET AL.
Examiner	Art Unit
Jon D. Epperson	1639

SEARCHED					
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
Palm (Inventor and Assignee) STN (MEDLINE) See Search History Printout	7/9/2005	JDE	
EAST (USPATFULL PCTFULL) (Invetor and Assignee) See Search History Printout	7/9/2005	JDE	
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